NOTES:

- 1. SUBSTRATE: FUSED SILICA
- 2. SURFACE S2 TO BE PARALLEL TO S1 TO WITHIN <3 ARCMIN
- 3. COATING (APPLY ACROSS COATING APERTURE)

S1: R(ABS) > 95% @ 266nm @ 45° AOI T(ABS) > 98% @ 532nm @ 45° AOI T(ABS) > 98% @ 1064nm @ 45° AOI

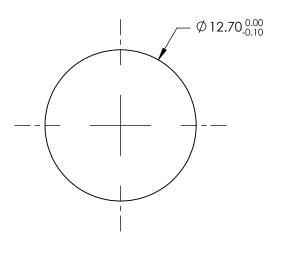
DAMAGE THRESHOLD, PULSED: 7.5 J/cm² @ 20ns, 20Hz @ 1064nm 5 J/cm² @ 20ns, 20Hz @ 532nm 1 J/cm² @ 20ns, 20Hz @ 266nm

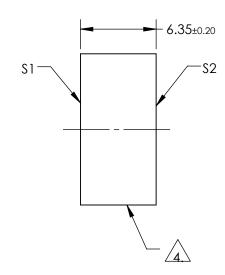
S2: R(ABS) < 1.0% @ 1064nm @ 45° AOI R(ABS) < 1.0% @ 532nm @ 45° AOI

DAMAGE THRESHOLD, PULSED: 15 J/cm² @ 20ns, 20Hz @ 1064nm 10 J/cm² @ 20ns, 20Hz @ 532nm

4. FINE GRIND SURFACE

5. ROHS COMPLIANT





FOR INFORMATION ONLY: DO NOT MANUFACTURE PARTS TO THIS DRAWING

SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

	S1	S2				
SHAPE	PLANO	PLANO	_		Edmund Ontice	C R
SURFACE ACCURACY P-V AT 632.8nm	0.10 WAVE	0.10 WAVE		U	Edmund Option	,5°
SURFACE QUALITY	10-5	10-5			Ø12.7mm HS 266R/532, 1064T HARMO	ONIC
CLEAR APERTURE	Ø11.43	Ø11.43	THIRD ANGLE PROJECTION	TITLE	BEAMSPLITTER	51410
COATING APERTURE	Ø11.43	Ø11.43			BEA WHOTE ETTER	CLIEFT
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	11545	SHEET 1 OF 1